WeEn Semiconductors

## 1. Global joint venture starts operations as WeEn Semiconductors

Dear customer,
As from November 9th, 2015 NXP Semiconductors N.V. and Beijing JianGuang Asset Management Co. Ltd established Bipolar Power joint venture (JV), WeEn Semiconductors, which will be used in future Bipolar Power documents together with new contact details.

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Thank you for your cooperation and understanding,
WeEn Semiconductors

BTA316X-600E

## 1. General description

Planar passivated high commutation three quadrant triac in a SOT186A "full pack" plastic package. The "series E" triac balances the requirements of commutation performance and gate sensitivity. The "sensitive gate" "series E" is intended for interfacing with low power drivers including microcontrollers.

## 2. Features and benefits

- 3Q technology for improved noise immunity
- Direct interfacing with low power drivers and microcontrollers
- Good immunity to false turn-on by dV/dt
- High commutation capability with sensitive gate
- High voltage capability
- Isolated mounting base package
- Planar passivated for voltage ruggedness and reliability
- Triggering in three quadrants only


## 3. Applications

- Electronic thermostats
- High power motor controls e.g. washing machines and vacuum cleaners


## 4. Quick reference data

Table 1. Quick reference data

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $V_{\text {DRM }}$ | repetitive peak offstate voltage |  | - | - | 600 | V |
| $\mathrm{I}_{\text {TSM }}$ | non-repetitive peak onstate current | full sine wave; $\mathrm{T}_{\mathrm{j} \text { (init) }}=25^{\circ} \mathrm{C}$; $\mathrm{t}_{\mathrm{p}}=20 \mathrm{~ms}$; Fig. 4; Fig. 5 | - | - | 140 | A |
| $\mathrm{I}_{\text {( } \mathrm{RMS} \text { ) }}$ | RMS on-state current | full sine wave; $T_{h} \leq 45^{\circ} \mathrm{C}$; Fig. 1; Fig. 2; Fig. 3 | - | - | 16 | A |
| Static characteristics |  |  |  |  |  |  |
| $\mathrm{I}_{\mathrm{GT}}$ | gate trigger current | $\begin{aligned} & \mathrm{V}_{\mathrm{D}}=12 \mathrm{~V} ; \mathrm{I}_{\mathrm{T}}=0.1 \mathrm{~A} ; \mathrm{T} 2+\mathrm{G}+; \\ & \mathrm{T}_{\mathrm{j}}=25^{\circ} \mathrm{C} \text {; Fig. } 7 \end{aligned}$ | - | - | 10 | mA |
|  |  | $\begin{aligned} & \mathrm{V}_{\mathrm{D}}=12 \mathrm{~V} ; \mathrm{I}_{\mathrm{T}}=0.1 \mathrm{~A} ; \mathrm{T} 2+\mathrm{G}-; \\ & \mathrm{T}_{\mathrm{j}}=25^{\circ} \mathrm{C} ; \text { Fig. } 7 \end{aligned}$ | - | - | 10 | mA |


| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | $\begin{aligned} & \mathrm{V}_{\mathrm{D}}=12 \mathrm{~V} ; \mathrm{I}_{\mathrm{T}}=0.1 \mathrm{~A} ; \mathrm{T} 2-\mathrm{G}-; \\ & \mathrm{T}_{\mathrm{j}}=25^{\circ} \mathrm{C} ; \underline{\text { Fig. } 7} \end{aligned}$ | - | - | 10 | mA |

## 5. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description | Simplified outline | Graphic symbol |
| :---: | :---: | :---: | :---: | :---: |
| 1 | T1 | main terminal 1 |  |  |
| 2 | T2 | main terminal 2 |  |  |
| 3 | G | gate |  |  |
| mb | n.c. | mounting base; isolated |  |  |
|  |  |  |  |  |
|  |  |  |  |  |

## 6. Ordering information

Table 3. Ordering information

| Type number | Package |  |  |
| :--- | :--- | :--- | :--- |
|  | Name | Description | Version |
| BTA316X-600E | TO-220F | plastic single-ended package; isolated heatsink mounted; 1 <br> mounting hole; 3-lead TO-220 "full pack" | SOT186A |
| BTA316X-600E/DG | TO-220F | plastic single-ended package; isolated heatsink mounted; 1 <br> mounting hole; 3-lead TO-220 "full pack" | SOT186A |

## 7. Limiting values

Table 4. Limiting values
In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {DRM }}$ | repetitive peak off-state voltage |  | - | 600 | V |
| $\mathrm{I}_{\text {( } \mathrm{RMS} \text { ) }}$ | RMS on-state current | full sine wave; $T_{h} \leq 45^{\circ} \mathrm{C}$; Fig. 1; Fig. 2; Fig. 3 | - | 16 | A |
| $\mathrm{I}_{\text {TSM }}$ | non-repetitive peak on-state current | full sine wave; $\mathrm{T}_{\mathrm{j} \text { (init) }}=25^{\circ} \mathrm{C}$; $\mathrm{t}_{\mathrm{p}}=20 \mathrm{~ms}$; Fig. 4; Fig. 5 | - | 140 | A |
|  |  | full sine wave; $\mathrm{T}_{\mathrm{j}(\text { (init) }}=25^{\circ} \mathrm{C}$; $\mathrm{t}_{\mathrm{p}}=16.7 \mathrm{~ms}$ | - | 150 | A |
| $\mathrm{I}^{2} \mathrm{t}$ | $I^{2} t$ for fusing | $\mathrm{t}_{\mathrm{p}}=10 \mathrm{~ms}$; SIN | - | 98 | $A^{2} s$ |
| $\mathrm{dl}_{\mathrm{T}} / \mathrm{dt}$ | rate of rise of on-state current | $\mathrm{I}_{\mathrm{T}}=20 \mathrm{~A} ; \mathrm{I}_{\mathrm{G}}=0.2 \mathrm{~A} ; \mathrm{dI}_{\mathrm{G}} / \mathrm{dt}=0.2 \mathrm{~A} / \mu \mathrm{s}$ | - | 100 | A/ $/ \mathrm{s}$ |
| $\mathrm{I}_{\mathrm{GM}}$ | peak gate current |  | - | 2 | A |
| $\mathrm{P}_{\mathrm{GM}}$ | peak gate power |  | - | 5 | W |
| $\mathrm{P}_{\mathrm{G}(\mathrm{AV})}$ | average gate power | over any 20 ms period | - | 0.5 | W |
| $\mathrm{T}_{\text {stg }}$ | storage temperature |  | -40 | 150 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\mathrm{j}}$ | junction temperature |  | - | 125 | ${ }^{\circ} \mathrm{C}$ |



Fig. 1. Total power dissipation as a function of RMS on-state current; maximum values


Fig. 2. RMS on-state current as a function of surge duration; maximum values


Fig. 3. RMS on-state current as a function of heatsink temperature; maximum values


Fig. 4. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values


Fig. 5. Non-repetitive peak on-state current as a function of pulse duration; maximum values

## 8. Thermal characteristics

Table 5. Thermal characteristics

| Symbol | Parameter | Conditions |  | Min | Typ | Max | Unit |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| $R_{\text {th(j-h) }}$ | thermal resistance <br> from junction to <br> heatsink | full cycle or half cycle; with heatsink <br> compound; Fig. 6 |  | - | - | 4 | K/W |
|  | full cycle or half cycle; without heatsink <br> compound; Fig. 6 |  | - | - | 5.5 | K/W |  |
| $R_{\text {th(j-a) }}$ | thermal resistance <br> from junction to <br> ambient | in free air |  | - | 55 | - | K/W |


$t_{p}(s)$
(1) Unidirectional (half cycle) without heatsink compound
(2) Unidirectional (half cycle) with heatsink compound
(3) Bidirectional (full cycle) without heatsink compound
(4) Bidirectional (full cycle) with heatsink compound

Fig. 6. Transient thermal impedance from junction to heatsink as a function of pulse duration

## 9. Isolation characteristics

Table 6. Isolation characteristics

| Symbol | Parameter | Conditions |  | Min | Typ | Max | Unit |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| $V_{\text {isol(RMS) }}$ | RMS isolation voltage | from all terminals to external heatsink; <br> sinusoidal waveform; clean and dust <br> free; $50 \mathrm{~Hz} \leq \mathrm{f} \leq 60 \mathrm{~Hz} ; \mathrm{RH} \leq 65 \% ;$ <br> $\mathrm{T}_{\mathrm{h}}=25^{\circ} \mathrm{C}$ |  | - | - | 2500 | V |
| $\mathrm{C}_{\text {isol }}$ | isolation capacitance | from main terminal 2 to external <br> heatsink; $\mathrm{f}=1 \mathrm{MHz} ; \mathrm{T}_{\mathrm{h}}=25^{\circ} \mathrm{C}$ |  | - | 10 | - | pF |

## 10. Characteristics

Table 7. Characteristics

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Static characteristics |  |  |  |  |  |  |
| $\mathrm{I}_{\text {GT }}$ | gate trigger current | $\begin{aligned} & \mathrm{V}_{\mathrm{D}}=12 \mathrm{~V} ; \mathrm{I}_{\mathrm{T}}=0.1 \mathrm{~A} ; \mathrm{T} 2+\mathrm{G}+; \\ & \mathrm{T}_{\mathrm{j}}=25^{\circ} \mathrm{C} \text {; Fig. } 7 \end{aligned}$ | - | - | 10 | mA |
|  |  | $\begin{aligned} & \mathrm{V}_{\mathrm{D}}=12 \mathrm{~V} ; \mathrm{I}_{\mathrm{T}}=0.1 \mathrm{~A} ; \mathrm{T} 2+\mathrm{G}-; \\ & \mathrm{T}_{\mathrm{j}}=25^{\circ} \mathrm{C} ; \text { Fig. } 7 \end{aligned}$ | - | - | 10 | mA |
|  |  | $\begin{aligned} & V_{D}=12 \mathrm{~V} ; \mathrm{I}_{\mathrm{T}}=0.1 \mathrm{~A} ; \text { T2- G-; } \\ & \mathrm{T}_{\mathrm{j}}=25^{\circ} \mathrm{C} ; \text { Fig. } 7 \end{aligned}$ | - | - | 10 | mA |
| $\mathrm{I}_{\mathrm{L}}$ | latching current | $\begin{aligned} & \mathrm{V}_{\mathrm{D}}=12 \mathrm{~V} ; \mathrm{I}_{\mathrm{G}}=0.1 \mathrm{~A} ; \mathrm{T} 2+\mathrm{G}+; \\ & \mathrm{T}_{\mathrm{j}}=25^{\circ} \mathrm{C} \text {; Fig. } 8 \end{aligned}$ | - | - | 25 | mA |
|  |  | $\begin{aligned} & \mathrm{V}_{\mathrm{D}}=12 \mathrm{~V} ; \mathrm{I}_{\mathrm{G}}=0.1 \mathrm{~A} ; \mathrm{T} 2+\mathrm{G}-; \\ & \mathrm{T}_{\mathrm{j}}=25^{\circ} \mathrm{C} \text {; Fig. } 8 \end{aligned}$ | - | - | 30 | mA |
|  |  | $\begin{aligned} & V_{D}=12 \mathrm{~V} ; \mathrm{I}_{\mathrm{G}}=0.1 \mathrm{~A} ; \mathrm{T} 2-\mathrm{G}-; \\ & \mathrm{T}_{\mathrm{j}}=25^{\circ} \mathrm{C} ; \text { Fig. } 8 \end{aligned}$ | - | - | 30 | mA |
| $\mathrm{I}_{\mathrm{H}}$ | holding current | $\mathrm{V}_{\mathrm{D}}=12 \mathrm{~V} ; \mathrm{T}_{\mathrm{j}}=25^{\circ} \mathrm{C} ;$ Fig. 9 | - | - | 25 | mA |
| $V_{T}$ | on-state voltage | $\mathrm{I}_{\mathrm{T}}=18 \mathrm{~A} ; \mathrm{T}_{\mathrm{j}}=25^{\circ} \mathrm{C} ;$ Fig. 10 | - | 1.3 | 1.5 | V |
| $V_{G T}$ | gate trigger voltage | $\mathrm{V}_{\mathrm{D}}=12 \mathrm{~V} ; \mathrm{I}_{\mathrm{T}}=0.1 \mathrm{~A} ; \mathrm{T}_{\mathrm{j}}=25^{\circ} \mathrm{C} ;$ <br> Fig. 11 | - | 0.8 | 1 | V |
|  |  | $\mathrm{V}_{\mathrm{D}}=400 \mathrm{~V} ; \mathrm{I}_{\mathrm{T}}=0.1 \mathrm{~A} ; \mathrm{T}_{\mathrm{j}}=125^{\circ} \mathrm{C} ;$ <br> Fig. 11 | 0.25 | 0.4 | - | V |
| $\mathrm{I}_{\mathrm{D}}$ | off-state current | $\mathrm{V}_{\mathrm{D}}=600 \mathrm{~V} ; \mathrm{T}_{\mathrm{j}}=125^{\circ} \mathrm{C}$ | - | 0.1 | 0.5 | mA |
| Dynamic characteristics |  |  |  |  |  |  |
| $\mathrm{dV} \mathrm{V}_{\mathrm{D}} / \mathrm{dt}$ | rate of rise of off-state voltage | $V_{D M}=402 \mathrm{~V} ; \mathrm{T}_{\mathrm{j}}=125^{\circ} \mathrm{C} ;\left(\mathrm{V}_{\mathrm{DM}}=67 \%\right.$ of $\mathrm{V}_{\mathrm{DRM}}$ ); exponential waveform; gate open circuit | 60 | - | - | V/us |
| $\mathrm{dl}_{\text {com }} / \mathrm{dt}$ | rate of change of commutating current | $\mathrm{V}_{\mathrm{D}}=400 \mathrm{~V} ; \mathrm{T}_{\mathrm{j}}=125^{\circ} \mathrm{C} ; \mathrm{I}_{\mathrm{T}(\mathrm{RMS})}=16 \mathrm{~A} ;$ <br> dV com $/ \mathrm{dt}=20 \mathrm{~V} / \mu \mathrm{s}$; (snubberless <br> condition); gate open circuit | 5 | - | - | A/ms |
|  |  | $\begin{aligned} & \mathrm{V}_{\mathrm{D}}=400 \mathrm{~V} ; \mathrm{T}_{\mathrm{j}}=125^{\circ} \mathrm{C} ; \mathrm{I}_{\mathrm{T}(\mathrm{RMS})}=16 \mathrm{~A} ; \\ & \mathrm{dV} \mathrm{~V}_{\text {com }} / \mathrm{dt}=10 \mathrm{~V} / \mathrm{Ls} ; \text { gate open circuit } \end{aligned}$ | 8 | - | - | A/ms |
|  |  | $V_{D}=400 \mathrm{~V} ; \mathrm{T}_{\mathrm{j}}=125^{\circ} \mathrm{C} ; \mathrm{I}_{\mathrm{T}(\mathrm{RMS})}=16 \mathrm{~A} ;$ <br> dV com $/ \mathrm{dt}=1 \mathrm{~V} / \mu \mathrm{s}$; gate open circuit | 12 | - | - | A/ms |



Fig. 7. Normalized gate trigger current as a function of junction temperature


Fig. 9. Normalized holding current as a function of junction temperature


Fig. 8. Normalized latching current as a function of junction temperature

$\mathrm{V}_{\mathrm{o}}=1.024 \mathrm{~V} ; \mathrm{R}_{\mathrm{s}}=0.021 \Omega$
(1) $T_{j}=125^{\circ} \mathrm{C}$; typical values
(2) $\mathrm{T}_{\mathrm{j}}=125^{\circ} \mathrm{C}$; maximum values
(3) $\mathrm{T}_{\mathrm{j}}=25^{\circ} \mathrm{C}$; maximum values

Fig. 10. On-state current as a function of on-state voltage


Fig. 11. Normalized gate trigger voltage as a function of junction temperature

## 11. Package outline

Plastic single-ended package; isolated heatsink mounted;
1 mounting hole; 3-lead TO-220 'full pack'


DIMENSIONS (mm are the original dimensions)

| UNIT | $\mathbf{A}$ | $\mathbf{A}_{\mathbf{1}}$ | $\mathbf{b}$ | $\mathbf{b}_{\mathbf{1}}$ | $\mathbf{b}_{\mathbf{2}}$ | $\mathbf{c}$ | $\mathbf{D}$ | $\mathbf{D}_{\mathbf{1}}$ | $\mathbf{E}$ | $\mathbf{e}$ | $\mathbf{e}_{\mathbf{1}}$ | $\mathbf{j}$ | $\mathbf{K}$ | $\mathbf{L}$ | $\mathbf{L}_{\mathbf{1}}$ | $\mathbf{L}_{\mathbf{2}}^{(\mathbf{1 )}}$ <br> $\mathbf{m a x}$. | $\mathbf{P}$ | $\mathbf{Q}$ | $\mathbf{q}$ | $\mathbf{T}^{(\mathbf{2})}$ | $\mathbf{w}$ |
| :--- | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| mm | 4.6 | 2.9 | 0.9 | 1.1 | 1.4 | 0.7 | 15.8 | 6.5 | 10.3 | 2.5 | 5.08 | 2.7 | 0.6 | 14.4 | 3.30 | 3 | 3.2 | 2.6 | 3.0 | 2.0 |  |
|  | 4.0 | 2.5 | 0.7 | 0.9 | 1.0 | 0.4 | 15.2 | 6.3 | 9.7 | 2.54 |  | 1.7 | 0.4 | 13.5 | 2.79 | 3 | 3.0 | 2.3 | 2.6 | 2.5 | 0.4 |

Notes

1. Terminal dimensions within this zone are uncontrolled.
2. Both recesses are \# $2.5 \times 0.8$ max. depth

| OUTLINE <br> VERSION | REFERENCES |  |  |  | EUROPEAN <br> PROJECTION | ISSUE DATE |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | IEC | JEDEC | JEITA |  |  | $-02-04-09$ |
| SOT186A |  | 3-lead TO-220F |  |  | $06-02-14$ |  |

Fig. 12. Package outline TO-220F (SOT186A)

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